Receipt date: 08/14/2006

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Form PTO 1449 (Modified)		U.S. DEPARTMEN PATENT AND TRA	FOF COMMERCE DEMARK OFFICE	294482US2PCT		New US PCT Application Based on PCT/JP05/06782		
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT				
				Yuji HASE, et al.				
				FILING DATE		GROUP		
				Herewith				
				U.S. PATENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB FILING DATE CLASS IF APPROPRIATE		
	AA	7 023 143	04/04/2006	HARADA et al.				
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	AC	2005 0179406	08/18/2005	HARADA et al.				
	AD				<u> </u>			
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			F0	REIGN PATENT DOCUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO		
	AO	63 245263	10/12/1988	JP (with English abstract)				NO
	AP	8 335497	12/17/1996	JP (with English abstract)				NO
	AQ	2002 15889	01/18/2002	JP (with English abstract)				NO
	AR	2002 352989	12/06/2002	JP (with English abstract)				NO
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW						_	
	AX							
	AY						_	
	AZ	-			Addit	ional Refe	rences s	sheet(s) attached
Examiner	/Ephrem Alemu/				Date Considered 12/06/2008			
*Examiner: In	itial if re	eference is considered, t considered, Include o	, whether or not	citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw lin	e through	citation	if not in